

<b>Search Notes</b>				Application/Control No.	Applicant(s)/Patent under Reexamination
				10/813,063	DELEEUW, WILLIAM C.
				Examiner	Art Unit
				Alan S. Chen	2182

<b>SEARCHED</b>			
Class	Subclass	Date	Examiner
710	2	7/17/2006	ASC
	5		
	8		
	11		
	36		
	59		
↓	62	↓	↓
limited class search			
updated		10/19/06	ASC

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner

<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT Inventor Search	7/17/2006	ASC
updated EAST	10/19/06	ASC
T+d Swann (QAS) 101 issues ⇒ Clus 18-20	10/23/06	ASC